## Application/Control No. Applicant(s)/Patent Under Reexamination NAKAGAWA, YOSHIHIRO Examiner Haresh Patel Applicant(s)/Patent Under Reexamination NAKAGAWA, YOSHIHIRO Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,564,104	05-2003	Nelson et al.	607/60
	В	US-6,564,323	05-2003	Takahashi et al.	713/182
	С	US-6,421,729	07-2002	Paltenghe et al.	709/229
į,	D	US-6,148,342	11-2000	Ho, Andrew P.	709/225
	Е	US-6,523,009	02-2003	Wilkins, Bobbi L.	705/3
	F	US-6,480,745	11-2002	Nelson et al.	607/60
	G	US-			
	н	US-			
	1	US-			
	j	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 950972 A2	10-1999	European Patent	PLATENGHE et al.	G06F 17/60
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

	NOW ALKI BOOMENTO						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U	Turner et al. US Publication 2003/0177030, Sep 18, 2003					
	٧	Sasaki et al. US 2002/0065685 A1, May 30, 2002					
	w	lliff US 2003/0135095, July 17, 2003,					
	x	Fey et al. US 2002/0038227, Mar 28, 2002					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.